

Synthesis, Structure, Magnetic and Electric Transport Properties of Zr_{0.5}Si_{0.5}Se_{1.90}

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Abstract

A new phase with the composition $Zr_{0.5}Si_{0.5}Se_{1.90}$ has been synthesised by the standard ceramic method. X-ray diffraction studies show that the phase crystallizes with the orthorhombic unit cell (a=14.221Å, b=13.557 and c=6.537Å). The molar magnetic susceptibility measurements as a function of temperature suggest that the phase is diamagnetic and magnetic susceptibility is temperature independent.

Keywords: Mixed binary dichalcogenides, XRD, Molar Magnetic Susceptibility.

Introduction:

Binary dichalcogenides of numerous elements with composition MX_2 and their mixed analogues $M_{1-x}M'X_2$ (M and M'are different transition elements; X=S, Se or Te) are known in the literature [1, 2]. Many dichalcogenides with reduced content of X are also known [3, 4]. It has been reported that structure and physical properties substantially vary with change in composition [1, 2, 3, 4]. It was thought interesting to prepare mixed chalcogenides with composition $M_{0.5}M'_{0.5}X_2$ study of their crystal structure& follow their magnetic properties as function of temperature. In the present study, synthesis of a new phase with the composition $Zr_{0.5}Si_{0.5}Se_{1.90}$ has been reported. Its crystal structure has been determined from the powder X-ray diffraction data. Magnetic properties have been studied in the temperature range 80K-300K.

Experiment:

Synthesis

Aldrich make Zirconium (Zr) Silicon (Si) and Selenium (Se) elements (purity 99.9%) have been used for synthesis of the new phase. The constituent elements weighed corresponding to the stoichiometry $Zr_{0.5}Si_{0.5}Se_{1.90}$, were mixed and homogenised by grinding in cyclohexane. The dried and homogenised mixture, pressed into pellets in hydraulic press was placed in quartz tube and evacuated to ~10⁻⁵ Torr, vacuum sealed and was heat- treated at 1048K for 72 hours. The mixture during the heat treatment was subjected to a number of intermediate grindings, pelletizing and sealing under same conditions for the completion of the reaction. The final product was pulverised to fine powder for further investigations [5, 6, 7].

Elemental Analysis

The phase was further analysed by atomic absorption spectrophotometry, which is one of the most prevalent methods for the trace element analysis [8, 9, 10]. The results of chemical elemental analysis [11, 12] and the atomic absorption spectrophotometry are in good agreement. The data are given in Table 1.



Table 1: Analytical data of the phase (Zr _{0.5} Si _{0.5} Se _{1.90}).	
The theoretical value is given parenthesis. Analysis (%))

Phase	Zr	Si	Se
$Zr_{0.5}Si_{0.5}Se_{1.90}$	20.84 (20.96)	6.35 (6.45)	68.95 (72.58)

X-ray Diffraction studies

Room temperature powder X-ray diffraction data of the product were recorded on a Stoe-powder diffraction system and a Philips diffractometer at a scanning speed of 1deg./minute in the 2θ range using CuK α and FeK α radiations [13, 14, 15]. The X- ray diffraction data are given in the Table 2, while the X-ray pattern, intensity, versus 2θ is drawn in the figure 1.

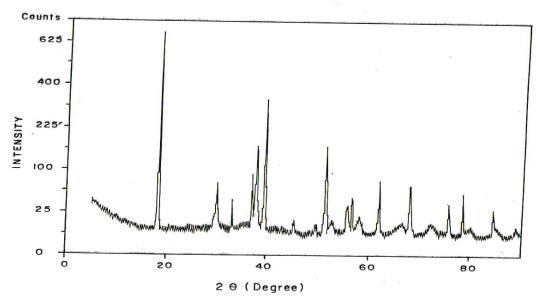


Figure 1: X-ray Diffraction pattern of Zr_{0.5}Si_{0.5}Se_{1.90}

Magnetic Susceptibility Measurement

Magnetic susceptibility of the powdered phase was recorded in a Faraday balance provided with Polytronic Faraday-type electromagnet and a Mettler microbalance. Specially fabricated Dewar flask of the size which could be adjusted within polegaps of electromagnet was used for keeping liquid nitrogen, which surrounded the phase crucible [16, 17]. The phase was held hanging in the inner tube of the Dewar flask with a fine thread. Magnetic susceptibility in the temperature range 77K-300K could be measured by this arrangement.

Results and Discussion

Crystal Structure

The unit cell parameters of the phase were calculated from X-ray diffraction data (Table 2). The indexing of the data shows that it crystallises in the orthorhombic unit cell with a=14.221Å, b=13.557 and c=6.537Å. In order to determine the crystal structure, the theoretical X-ray diffraction data were generated by Treor and Lazy- Pulverix analysis. The d_{cal} values computed from data are in good



agreement with the experimental interplanar distances. The data along with the assigned h k l values are given in the Table 2.

Table 2: Powder X-ray Diffraction Data of Zr _{0.5} Si _{0.5} Se _{1.90}							
h	k	l	d _{obs} (Å)	d _{cal} (Å)	I _{obs}		
1	2	0	6.123	6.124	100.0		
4	1	0	3.431	3.441	18.6		
2	4	0	3.060	3.062	12.1		
0	4	1	3.000	3.011	21.6		
1	2	2	2.880	2.885	46.5		
3	3	2	2.308	2.313	0.7		
2	4	2	2.234	2.235	18.9		
0	0	3	2.181	2.180	1.3		
5	4	1	2.066	2.068	3.8		
3	6	0	2.041	2.041	5.2		
2	2	3	1.993	1.993	2.0		
4	5	2	1.801	1.801	1.7		
8	1	0	1.762	1.764	1.8		
3	6	2	1.731	1.731	8.8		
2	5	3	1.651	1.653	0.9		
6	0	3	1.604	1.605	0.7		
7	5	1	1.577	1.579	4.6		
4	5	3	1.532	1.533	6.3		
2	3	4	1.502	1.503	0.9		
1	7	3	1.440	1.441	3.0		

a=14.221Å b=13.557c=6.537Å

1.385

Magnetic susceptibility studies

The molar magnetic susceptibility measurements as a function of temperature suggest that the phase is diamagnetic and magnetic susceptibility is temperature independent.

Conclusion:

A new phase with the composition Zr_{0.5}Si_{0.5}Se_{1.90} has been synthesised by the standard ceramic method. On the basis of Lazy-Pulverix analysis of the X-ray diffraction data it is concluded that the phase crystallises in the orthorhombic unit cell. The molar magnetic susceptibility (χ_m) measurements as a function of temperature suggest that the phase is diamagnetic and magnetic susceptibility is temperature independent.

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1.386

1.3



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